

# Yuh-Chen Lin

## List of Publications by Year in descending order

Source: <https://exaly.com/author-pdf/3435517/publications.pdf>

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6  
papers

399  
citations

1684188

5  
h-index

1872680

6  
g-index

6  
all docs

6  
docs citations

6  
times ranked

881  
citing authors

#	ARTICLE	IF	CITATIONS
1	Short-channel robustness from negative capacitance in 2D NC-FETs. Applied Physics Letters, 2021, 118, .	3.3	9
2	Uniform and Stable Aerosol Jet Printing of Carbon Nanotube Thin-Film Transistors by Ink Temperature Control. ACS Applied Materials & Interfaces, 2020, 12, 43083-43089.	8.0	34
3	Effects of Gate Stack Composition and Thickness in 2-D Negative Capacitance FETs. IEEE Journal of the Electron Devices Society, 2019, 7, 645-649.	2.1	3
4	Immunity to Contact Scaling in MoS <sub>2</sub> Transistors Using in Situ Edge Contacts. Nano Letters, 2019, 19, 5077-5085.	9.1	76
5	Realizing ferroelectric Hf <sub>0.5</sub> Zr <sub>0.5</sub> O <sub>2</sub> with elemental capping layers. Journal of Vacuum Science and Technology B: Nanotechnology and Microelectronics, 2018, 36, .	1.2	40
6	Sustained Sub-60 mV/decade Switching via the Negative Capacitance Effect in MoS <sub>2</sub> Transistors. Nano Letters, 2017, 17, 4801-4806.	9.1	237